



STL150N3LLH5

N-channel 30 V, 0.0014 Ω , 35 A - PowerFLAT™ (6x5)
STripFET™ V Power MOSFET

Features

| Type | V _{DSS} | R _{DS(on) max} | I _D |
|--------------|------------------|-------------------------|---------------------|
| STL150N3LLH5 | 30 V | <0.00175 Ω | 35 A ⁽¹⁾ |

1. The value is rated according R_{thj-pcb}

- R_{DS(on)} * Q_g industry benchmark
- Extremely low on-resistance R_{DS(on)}
- High avalanche ruggedness
- Low gate drive power losses

Application

- Switching applications

Description

This product utilizes the 5th generation of design rules of ST's proprietary STripFET™ technology. The lowest available R_{DS(on)}*Q_g, in this chip scale package, makes this device suitable for the most demanding DC-DC converter applications, where high power density is to be achieved.

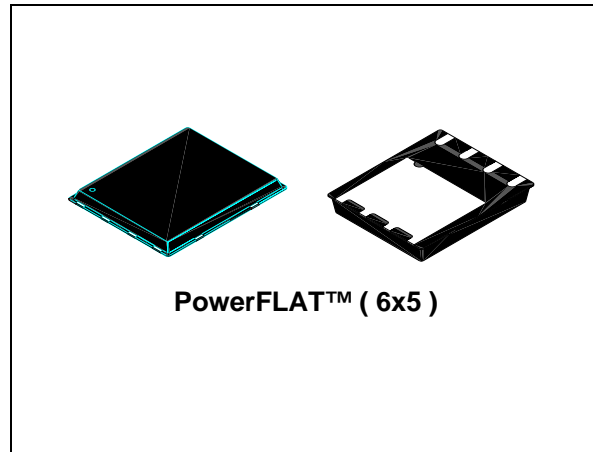


Figure 1. Internal schematic diagram

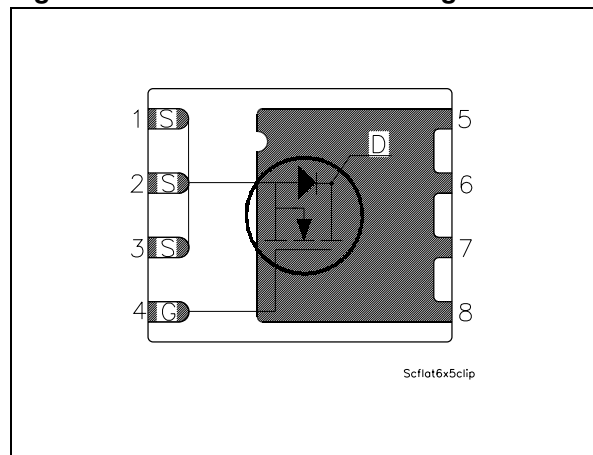


Table 1. Device summary

| Order code | Marking | Package | Packaging |
|--------------|-----------|------------------|---------------|
| STL150N3LLH5 | 150N3LLH5 | PowerFLAT™ (6x5) | Tape and reel |

Contents

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1 Electrical ratings

Table 2. Absolute maximum ratings

| Symbol | Parameter | Value | Unit |
|-----------------|---|------------|---------------------|
| V_{DS} | Drain-source voltage ($V_{GS} = 0$) | 30 | V |
| V_{GS} | Gate-source voltage | ± 22 | V |
| $I_D^{(1)}$ | Drain current (continuous) at $T_C = 25\text{ }^\circ\text{C}$ | 150 | A |
| $I_D^{(1)}$ | Drain current (continuous) at $T_C = 100\text{ }^\circ\text{C}$ | 94 | A |
| $I_D^{(2)}$ | Drain current (continuous) at $T_C = 25\text{ }^\circ\text{C}$ | 35 | A |
| $I_D^{(3)}$ | Drain current (continuous) at $T_C = 100\text{ }^\circ\text{C}$ | 21.8 | A |
| $I_{DM}^{(3)}$ | Drain current (pulsed) | 140 | A |
| $P_{TOT}^{(1)}$ | Total dissipation at $T_C = 25\text{ }^\circ\text{C}$ | 80 | W |
| $P_{TOT}^{(3)}$ | Total dissipation at $T_C = 25\text{ }^\circ\text{C}$ | 4 | W |
| | Derating factor | 0.03 | W/ $^\circ\text{C}$ |
| T_J | Operating junction temperature | -55 to 150 | $^\circ\text{C}$ |
| T_{stg} | Storage temperature | | |

1. The value is rated according R_{thj-c}
2. The value is rated according $R_{thj-pcb}$
3. Pulse width limited by safe operating area

Table 3. Thermal resistance

| Symbol | Parameter | Value | Unit |
|---------------------|---|-------|---------------------------|
| $R_{thj-case}$ | Thermal resistance junction-case (drain) (steady state) | 1.56 | $^\circ\text{C}/\text{W}$ |
| $R_{thj-pcb}^{(1)}$ | Thermal resistance junction-ambient | 31.3 | $^\circ\text{C}/\text{W}$ |

1. When mounted on FR-4 board of 1inch², 2oz Cu, $t < 10\text{ sec}$

Table 4. Avalanche data

| Symbol | Parameter | Value | Unit |
|----------|---|-------|------|
| I_{AV} | Not-repetitive avalanche current, (pulse width limited by $T_J \text{ Max}$) | 17 | A |
| E_{AS} | Single pulse avalanche energy (starting $T_J = 25\text{ }^\circ\text{C}$, $I_D = I_{AV}$, $V_{DD} = 24\text{ V}$) | 300 | mJ |

2 Electrical characteristics

($T_{CASE} = 25\text{ °C}$ unless otherwise specified)

Table 5. On/off states

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|---------------|--|---|------|------------------|-------------------|--------------------------------|
| $V_{(BR)DSS}$ | Drain-source breakdown voltage | $I_D = 250\ \mu\text{A}$, $V_{GS} = 0$ | 30 | | | V |
| I_{DSS} | Zero gate voltage drain current ($V_{GS} = 0$) | $V_{DS} = \text{Max rating}$, $V_{DS} = \text{Max rating @ } 125\text{ °C}$ | | | 1 10 | μA μA |
| I_{GSS} | Gate body leakage current ($V_{DS} = 0$) | $V_{GS} = \pm 22\text{ V}$ | | | ± 100 | nA |
| $V_{GS(th)}$ | Gate threshold voltage | $V_{DS} = V_{GS}$, $I_D = 250\ \mu\text{A}$ | 1 | | | V |
| $R_{DS(on)}$ | Static drain-source on resistance | $V_{GS} = 10\text{ V}$, $I_D = 17.5\text{ A}$ $V_{GS} = 4.5\text{ V}$, $I_D = 17.5\text{ A}$ | | 0.0014 0.0019 | 0.00175 0.0024 | Ω Ω |

Table 6. Dynamic

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------|------------------------------|---|------|------|------|----------|
| C_{iss} | Input capacitance | $V_{DS} = 25\text{ V}$, $f = 1\text{ MHz}$, $V_{GS} = 0$ | | 5800 | | pF |
| C_{oss} | Output capacitance | | | 1147 | | pF |
| C_{rss} | Reverse transfer capacitance | | | 127 | | pF |
| Q_g | Total gate charge | $V_{DD} = 15\text{ V}$, $I_D = 35\text{ A}$ $V_{GS} = 4.5\text{ V}$ <i>(see Figure 14)</i> | | 40 | | nC |
| Q_{gs} | Gate-source charge | | | 13.4 | | nC |
| Q_{gd} | Gate-drain charge | | | 14.9 | | nC |
| R_G | Gate input resistance | $f = 1\text{ MHz}$ Gate DC Bias = 0 Test signal level = 20 mV open drain | | 1.1 | | Ω |

Table 7. Switching times

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|--------------|---------------------|--|------|------|------|------|
| $t_{d(on)}$ | Turn-on delay time | $V_{DD}=15\text{ V}$, $I_D=17.5\text{ A}$, $R_G=4.7\ \Omega$, $V_{GS}=10\text{ V}$ <i>(see Figure 13)</i> | | 17.2 | | ns |
| t_r | Rise time | | | 30.8 | | ns |
| $t_{d(off)}$ | Turn-off delay time | | | 65.8 | | ns |
| t_f | Fall time | | | 47.8 | | ns |

Table 8. Source drain diode

| Symbol | Parameter | Test conditions | Min | Typ. | Max | Unit |
|-----------------|-------------------------------|--|-----|------|-----|------|
| I_{SD} | Source-drain current | | | | 35 | A |
| $I_{SDM}^{(1)}$ | Source-drain current (pulsed) | | | | 140 | A |
| $V_{SD}^{(2)}$ | Forward on voltage | $I_{SD} = 35\text{ A}$, $V_{GS}=0$ | | | 1.1 | V |
| t_{rr} | Reverse recovery time | $I_{SD} = 35\text{ A}$, $di/dt = 100\text{ A}/\mu\text{s}$, $V_{DD}=25\text{ V}$ | | 43.8 | | ns |
| Q_{rr} | Reverse recovery charge | | | 46 | | nC |
| I_{RRM} | Reverse recovery current | | | 2.1 | | A |

1. Pulse width limited by safe operating area
2. Pulsed: pulse duration=300 μs , duty cycle 1.5%

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

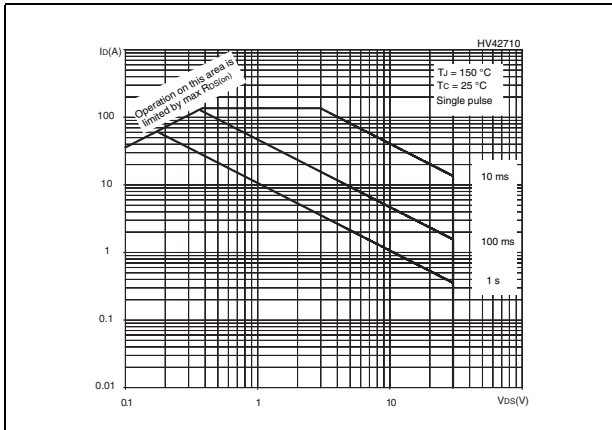


Figure 3. Thermal impedance

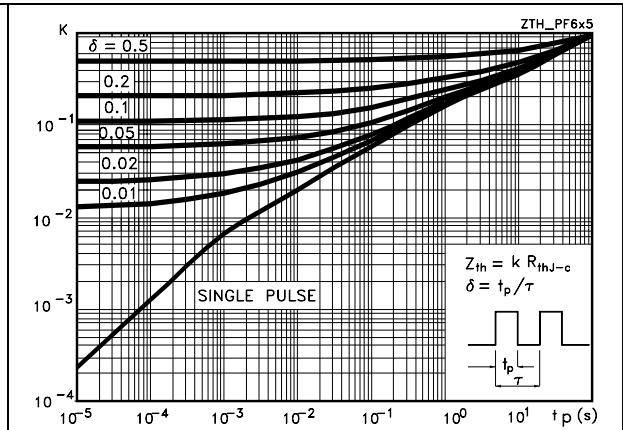


Figure 4. Output characteristics

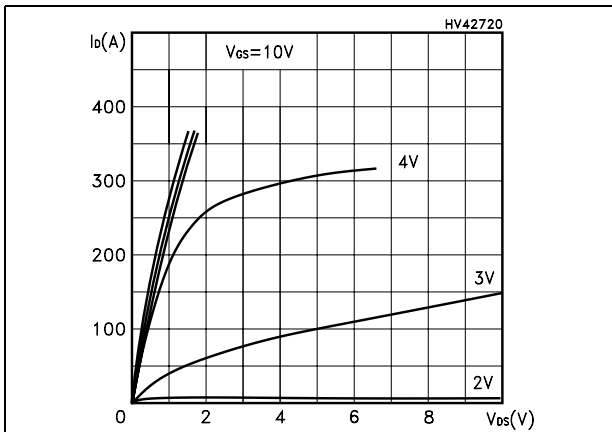


Figure 5. Transfer characteristics

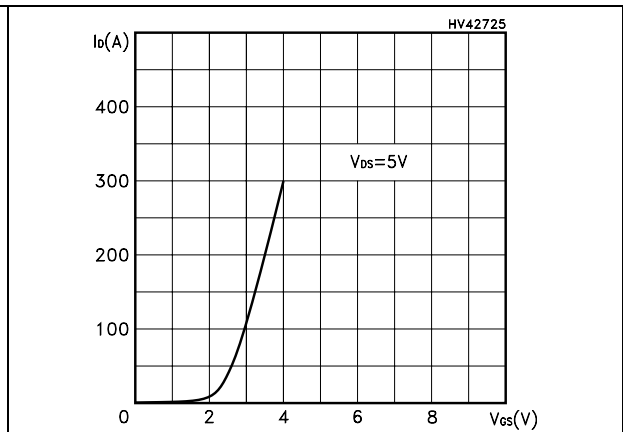


Figure 6. Normalized B_{VDSS} vs temperature

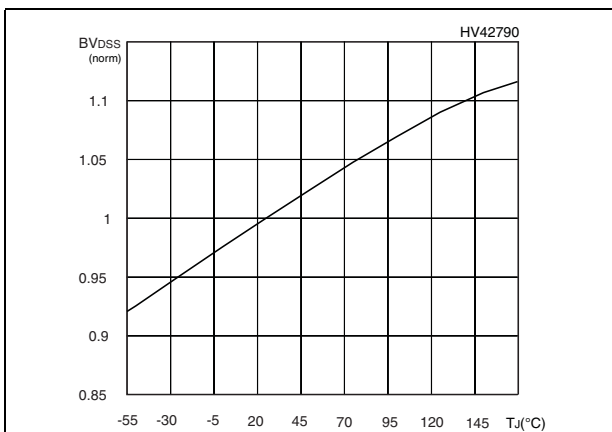


Figure 7. Static drain-source on resistance

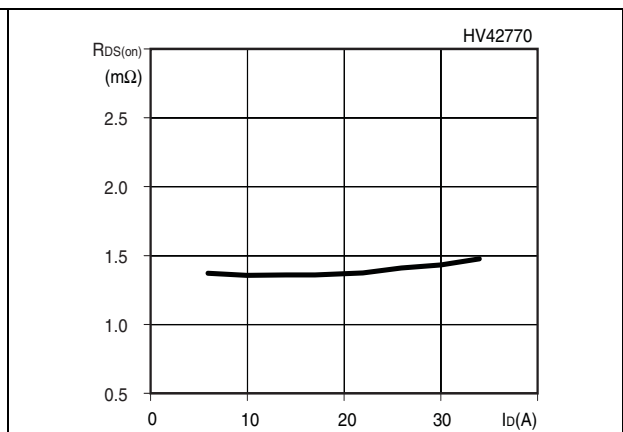


Figure 8. Gate charge vs gate-source voltage Figure 9. Capacitance variations

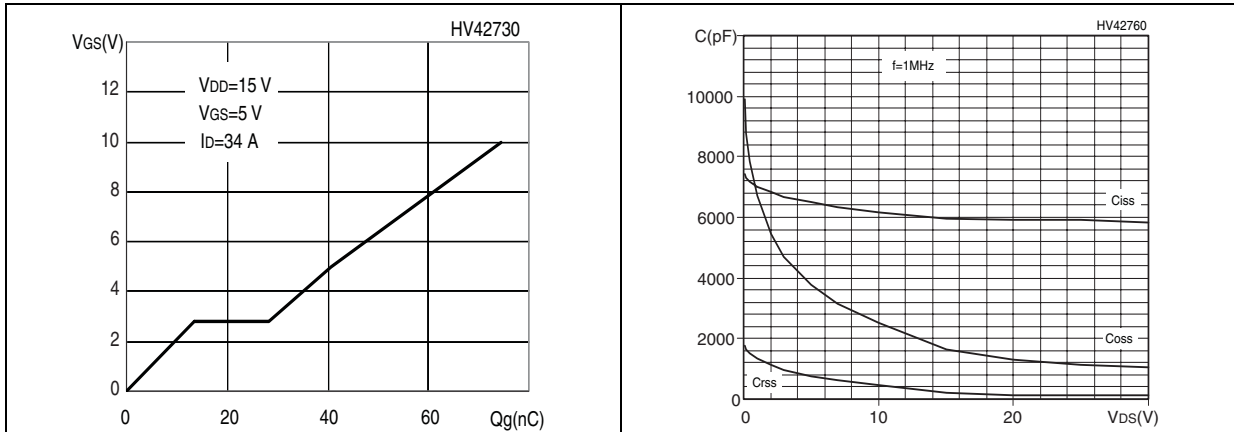


Figure 10. Normalized gate threshold voltage vs temperature Figure 11. Normalized on resistance vs temperature

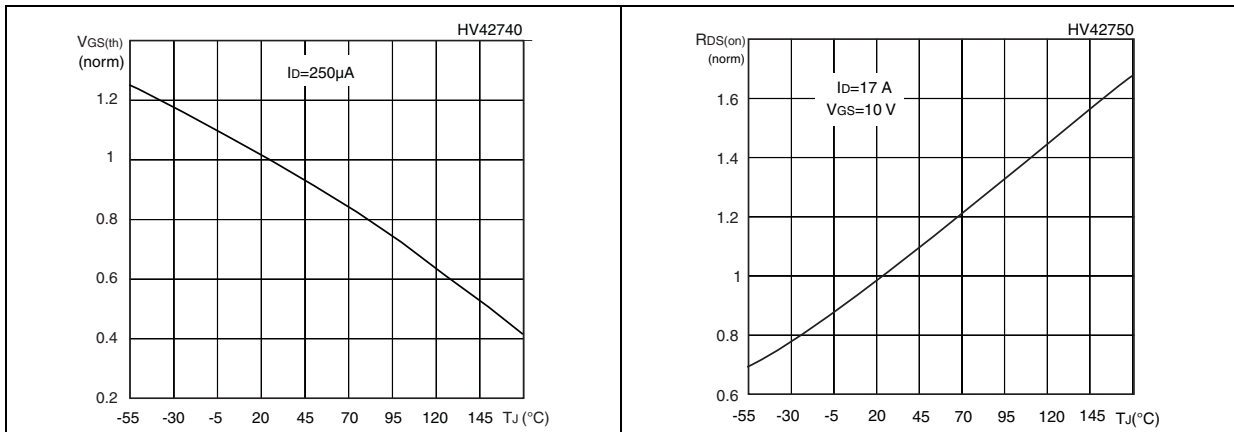
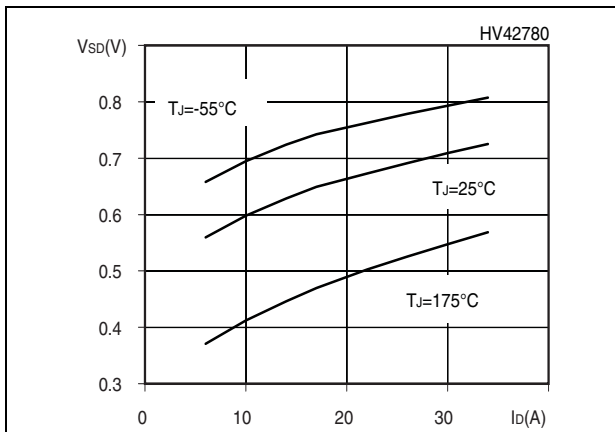


Figure 12. Source-drain diode forward characteristics



3 Test circuits

Figure 13. Switching times test circuit for resistive load

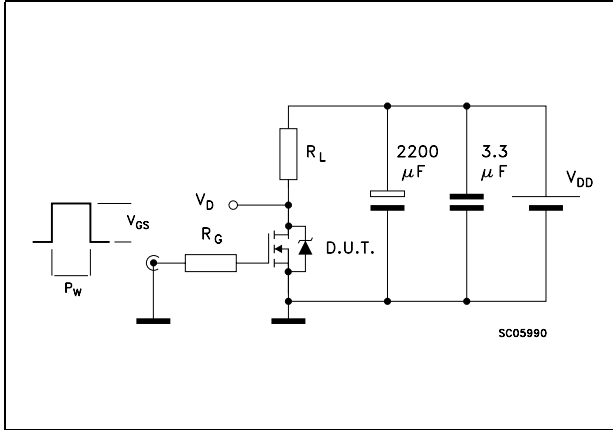


Figure 14. Gate charge test circuit

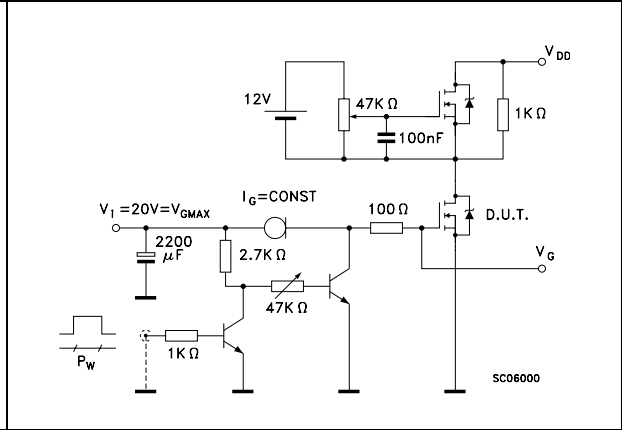


Figure 15. Test circuit for inductive load switching and diode recovery times

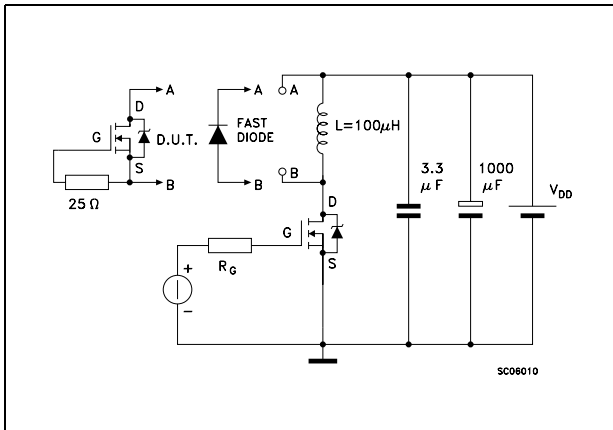


Figure 16. Unclamped inductive load test circuit

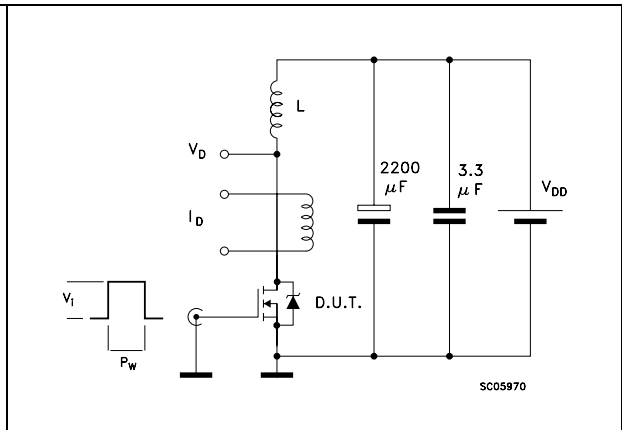
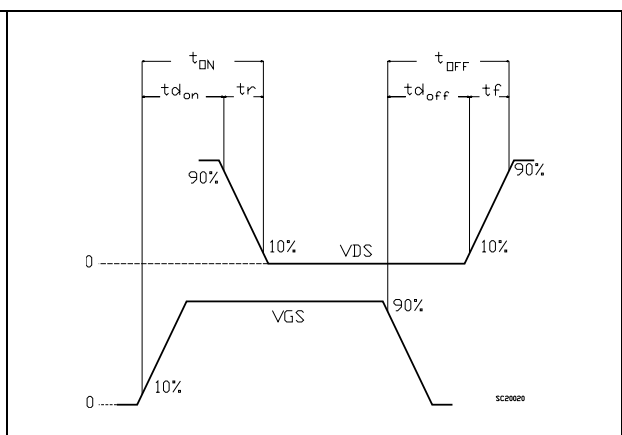


Figure 17. Unclamped inductive waveform



Figure 18. Switching time waveform

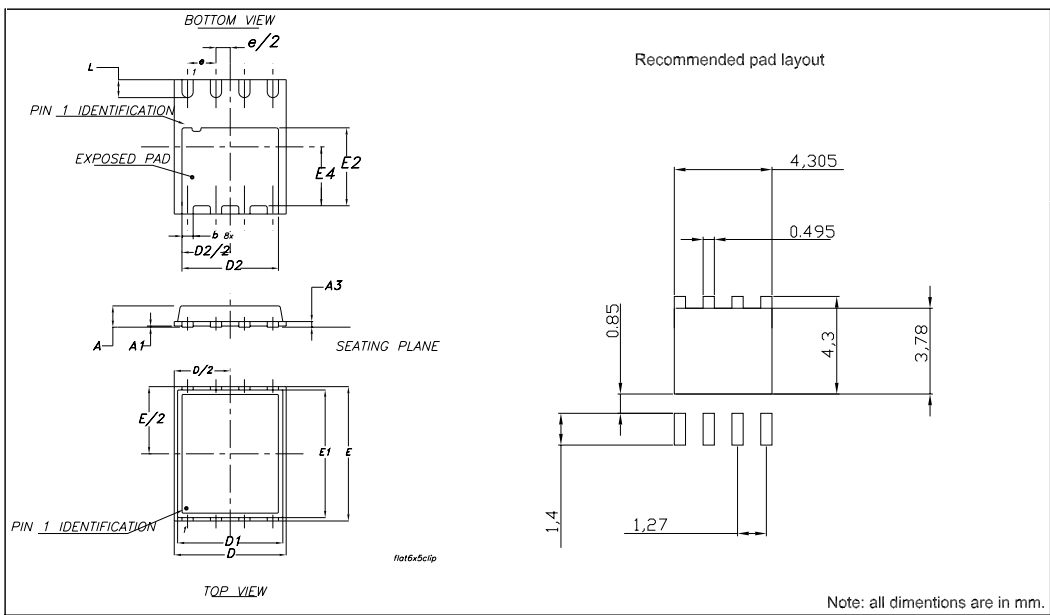


4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

PowerFLAT™ (6x5) mechanical data

| DIM. | mm. | | | inch | | |
|------|------|------|------|-------|--------|--------|
| | Min. | Typ. | Max. | Min. | Typ. | Max. |
| A | 0.80 | 0.83 | 0.93 | 0.031 | 0.032 | 0.036 |
| A1 | | 0.02 | 0.05 | | 0.0007 | 0.0019 |
| A3 | | 0.20 | | | 0.007 | |
| b | 0.35 | 0.40 | 0.47 | 0.013 | 0.015 | 0.018 |
| D | | 5.00 | | | 0.196 | |
| D1 | | 4.75 | | | 0.187 | |
| D2 | 4.15 | 4.20 | 4.25 | 0.163 | 0.165 | 0.167 |
| E | | 6.00 | | | 0.236 | |
| E1 | | 5.75 | | | 0.226 | |
| E2 | 3.43 | 3.48 | 3.53 | 0.135 | 0.137 | 0.139 |
| E4 | 2.58 | 2.63 | 2.68 | | 0.103 | 0.105 |
| e | | 1.27 | | | 0.050 | |
| L | 0.70 | 0.80 | 0.90 | 0.027 | 0.031 | 0.035 |



5 Revision history

Table 9. Document revision history

| Date | Revision | Changes |
|-------------|----------|--|
| 22-Oct-2007 | 1 | First release |
| 01-Apr-2008 | 2 | Document status promoted from preliminary data to datasheet |
| 23-Sep-2008 | 3 | V_{GS} value has been changed on Table 2 and Table 5 |

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